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# Vishay Siliconix

# P-Channel 20 V (D-S) MOSFET



PRODUCT SUMMARY				
V <sub>DS</sub> (V)	-20			
$R_{DS(on)}$ max. ( $\Omega$ ) at $V_{GS} = -4.5 \text{ V}$	0.0098			
$R_{DS(on)}$ max. ( $\Omega$ ) at $V_{GS} = -2.5$ V	0.0130			
$R_{DS(on)}$ max. ( $\Omega$ ) at $V_{GS} = -1.8$ V	0.0227			
Q <sub>g</sub> typ. (nC)	63			
I <sub>D</sub> (A) <sup>d</sup>	-18			
Configuration	Single			

#### **FEATURES**

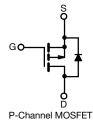
- TrenchFET® power MOSFET
- 100 % R<sub>g</sub> and UIS tested
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912



ROHS COMPLIANT HALOGEN FREE

#### **APPLICATIONS**

- · Load switch
- · Battery switch
- Power management



ORDERING INFORMATION	
Package	TSSOP-8
Lead (Pb)-free and halogen-free	Si6423ADQ-T1-GE3

PARAMETER		SYMBOL	LIMIT	UNIT
Drain-source voltage		$V_{DS}$	-20	V
Gate-source voltage		$V_{GS}$	± 8	V
Continuous drain current (T <sub>J</sub> = 150 °C) <sup>a</sup>	T <sub>C</sub> = 25 °C		-12.5	•
	T <sub>C</sub> = 70 °C	- I <sub>D</sub>	-10	
	T <sub>A</sub> = 25 °C		-10.3 <sup>a, b</sup>	
	T <sub>A</sub> = 70 °C		-8.2 <sup>a, b</sup>	
Pulsed drain current (t = 300 μs)		I <sub>DM</sub>	I <sub>DM</sub> -70	A
	T <sub>C</sub> = 25 °C		-1.9	
Continuous source-drain diode current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	-1.3	
Avalanche current	L = 0.1 mH	I <sub>AS</sub>	-20	
Single pulse avalanche energy	•	E <sub>AS</sub>	20	mJ
Maximum power dissipation	T <sub>C</sub> = 25 °C	- P <sub>D</sub>	2.2	W
	T <sub>C</sub> = 70 °C		1.4	
	T <sub>A</sub> = 25 °C		1.5 <sup>a, b</sup>	
	T <sub>A</sub> = 70 °C		1.0 <sup>a, b</sup>	
Operating junction and storage temperature range		T <sub>J</sub> , T <sub>sta</sub>	-55 to +150	°C

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction-to-ambient a, c	t ≤ 10 s	$R_{thJA}$	65	83	°C/W	
Maximum junction-to-case (drain)	Steady state	$R_{thJC}$	46	56	]	

#### Notes

- a. Surface mounted on 1" x 1" FR4 board
- b. t = 10 s
- c. Maximum under steady state conditions is 120 °C/W
- d.  $T_C = 25$  °C

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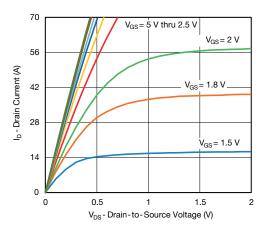
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static						
Drain-source breakdown voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-20	-	-	V
V <sub>DS</sub> temperature coefficient	$\Delta V_{DS}/T_{J}$		-	-11	-	mV/°C
V <sub>GS(th)</sub> temperature coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = -250 μA	-	2.9	-	
Gate-source threshold voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	-0.4	-	-1	V
Gate-source leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$	-	=	± 100	nA
Zoro noto voltono duoin avuvent	-	V <sub>DS</sub> = -20 V, V <sub>GS</sub> = 0 V	-	-	-1	μA
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>DS</sub> = -20 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C	-	-	-10	
On-state drain current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le -5 \text{ V}, V_{GS} = -10 \text{ V}$	-10	-	-	Α
Drain-source on-state resistance <sup>a</sup>		V <sub>GS</sub> = -4.5 V, I <sub>D</sub> = -10 A	-	0.0082	0.0098	Ω
	R <sub>DS(on)</sub>	V <sub>GS</sub> = -2.5 V, I <sub>D</sub> = -8 A	-	0.0108	0.0130	
		V <sub>GS</sub> = -1.8 V, I <sub>D</sub> = -5 A	-	0.0175	0.0227	
Forward transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = -10 V, I <sub>D</sub> = -10 A	-	70	-	S
Dynamic <sup>b</sup>						
Input capacitance	C <sub>iss</sub>	V <sub>DS</sub> = -10 V, V <sub>GS</sub> = 0 V, f = 1 MHz	-	5875	-	pF
Output capacitance	Coss		-	540	-	
Reverse transfer capacitance	C <sub>rss</sub>		-	555	-	
Total gata abayes		V <sub>DS</sub> = -10 V, V <sub>GS</sub> = -8 V, I <sub>D</sub> = -16.7 A	-	112	168	nC
Total gate charge	$Q_g$	V <sub>DS</sub> = -10 V, V <sub>GS</sub> = -4.5 V, I <sub>D</sub> = -16.7 A	-	63	95	
Gate-source charge	Q <sub>gs</sub>		-	8.7	-	
Gate-drain charge	$Q_{gd}$	]	-	25.3	-	
Gate resistance	Rg	f = 1 MHz	0.8	3.6	7.2	Ω
Turn-on delay time	t <sub>d(on)</sub>		-	12	24	
Rise time	t <sub>r</sub>	$V_{DD} = -10 \text{ V}, R_{I} = 1 \Omega,$	-	4	8	ns
Turn-off delay time	t <sub>d(off)</sub>	$I_D \cong -10 \text{ A}, V_{GEN} = -8 \text{ V}, R_g = 1 \Omega$	-	120	180	
Fall time	t <sub>f</sub>	]	-	36	54	
Drain-Source Body Diode Characteristic	cs					
Continuous source-drain diode current	Is	T <sub>C</sub> = 25 °C	-	-	-18	^
Pulse diode forward current <sup>a</sup>	I <sub>SM</sub>		-	-	-70	A
Body diode voltage	$V_{SD}$	I <sub>S</sub> = -10 A	-	-0.75	-1.2	V
Body diode reverse recovery time	t <sub>rr</sub>	I <sub>F</sub> = -10 A, di/dt = 100 A/μs, T <sub>J</sub> = 25 °C	-	45	68	ns
Body diode reverse recovery charge	Q <sub>rr</sub>		-	38	57	nC
		1 I = 1 I I A MI/MT - 1 I I I A/II S   I   - 25 °( :		1		
Reverse recovery fall time	ta		-	18	-	ns

#### Notes

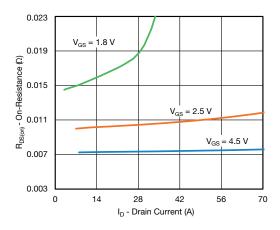
- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%$
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

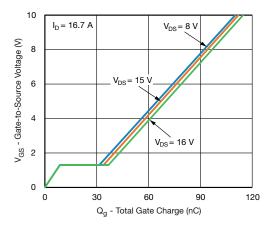




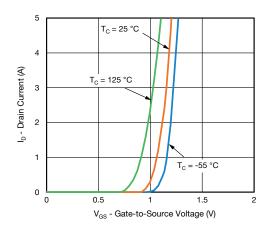
#### **Output Characteristics**



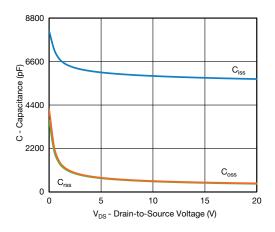
On-Resistance vs. Drain Current



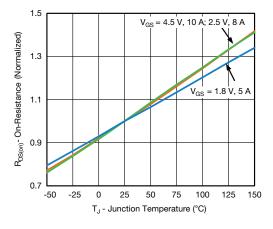
**Gate Charge** 



**Transfer Characteristics** 

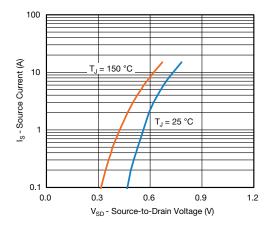


Capacitance

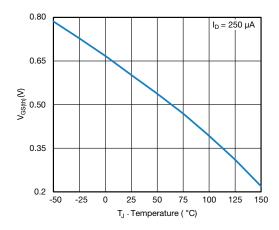


Normalized On-Resistance vs. Junction Temperature

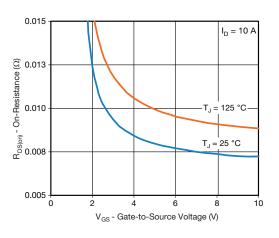




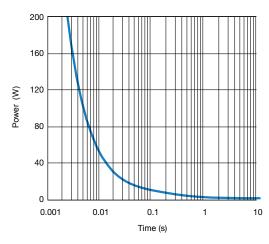
#### Source-Drain Diode Forward Voltage



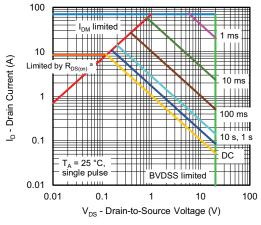
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

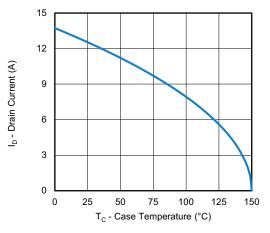


Safe Operating Area, Junction-to-Ambient

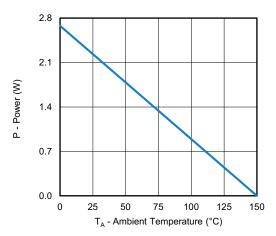
#### Note

a.  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

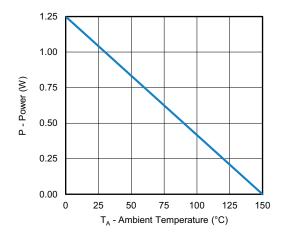




#### Current Derating a





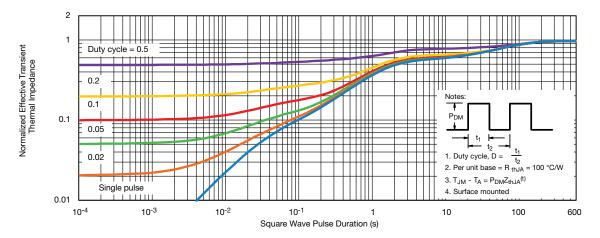


Power, Junction-to-Ambient

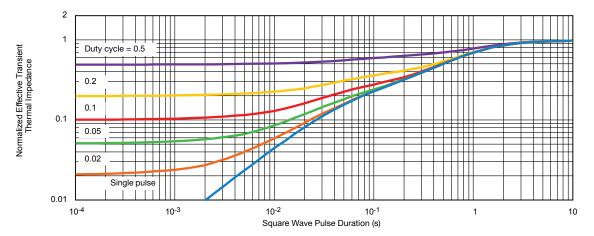
#### Note

a. The power dissipation P<sub>D</sub> is based on T<sub>J</sub> max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





#### Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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